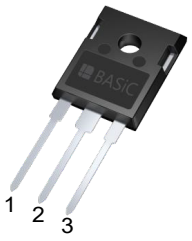
B2M065120H

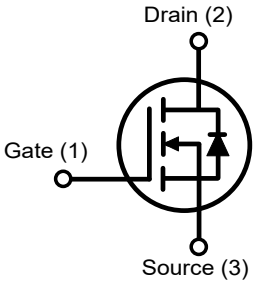
SiC MOSFET

Product Summary

V_{DS}	1200 V
I_D (T_C=25°C)	47 A
$R_{DS(on).typ}$	65 mΩ@V_{GS}=18V

Package: TO-247-3





Features

- Low On-Resistance with High Blocking Voltage
- Low Capacitance
- Avalanche Ruggedness
- Halogen Free, Rohs Compliant

Benefits

- High Frequency Operation
- Enabling Higher Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements

Applications

- Switch Mode Power Supplies (SMPS)
- Power Inverter & Solar Inverter
- Motor Drivers & EV Charging Station
- DC/DC Converter

Package Pin Definitions

- Pin1 - Gate
- Pin2 - Drain
- Pin3 - Source

Package Parameters

Part Number	Marking	Package
B2M065120H	B2M065120H	TO-247-3

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Maximum Ratings

Symbol	Parameter	Test conditions	Value	Unit
V_{DSmax}	Drain-Source Voltage	V_{GS}=0V, I_D=100μA	1200	V
V_{GSmax} 1)	Gate-Source Voltage		-8/22	V
V_{GSop}	Recommend Gate-Source Voltage		-4/18	V
I_D	Continuous Drain Current	V_{GS}=18V, T_C=25°C	47	A
		V_{GS}=18V, T_C=100°C	33	A
$I_{D,pulse}$	Pulsed Drain Current	Pulse with t_p limited by T_{jmax}	85	A
P_{tot}	Power Dissipation	T_C=25°C, T_j=175°C	250	W
T_j	Operating Junction Temperature		-55~175	°C
T_{stg}	Storage Temperature		-55~175	°C
M_d	TO-247 mounting torque	M3 Screw	0.7	N·m

1) Note: When using MOSFET Body Diode V_{GSmax}=-4/22V

Electrical Characteristics (Defined at T_j=25°C unless otherwise specified)

Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=100μA	1200			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{GS}=V_{DS}, I_D=5mA	2.3	2.8	3.5	V
		V_{GS}=V_{DS}, I_D=5mA,T_j=175°C		1.9		
I_{GSS}	Gate-Source Leakage Current	V_{GS}=18V, V_{DS}=0V			100	nA
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=1200V, V_{GS}=0V		1	50	μA
		V_{DS}=1200V, V_{GS}=0V,T_j=175°C		10	200	
$R_{DS(on)}$	Drain-Source On-State Resistance	V_{GS}=18V, I_D=20A		65	90	mΩ
		V_{GS}=18V, I_D=20A,T_j=175°C		110		
g_{fs}	Transconductance	V_{DS}=10V, I_D=20A		8.5		S

Thermal Characteritics

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal Resistance from Junction to Case		0.60		K/W

AC Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=800V f=1MHz, V_{AC}=25mV		1300		pF
C_{oss}	Output Capacitance			75		pF
C_{rss}	Reverse Transfer Capacitance			3		pF
$R_{G(int)}$	Internal Gate Resistance	f=1MHz, V_{AC}=25mV		1.8		Ω

Gate Charge Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
Q_{GS}	Gate to Source Charge	V_{DS}=800V I_D =20A V_{GS}=-4/+18V		18		nC
Q_{GD}	Gate to Drain Charge			30		nC
Q_G	Total Gate Charge			60		nC

Switching Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-On Delay Time	V_{DC}=800V, V_{GS}=-4/18V I_D=20A, $R_{G(ext)}$=2.2Ω L_σ=80nH, T_j=25°C Inductive Load Eon includes diode reverse recovery		25		ns
t_r	Rise Time			13		ns
$t_{d(off)}$	Turn-Off Delay Time			13		ns
t_f	Fall Time			9		ns
E_{on}	Turn-On Energy			350		uJ
E_{off}	Turn-Off Energy			60		uJ
$t_{d(on)}$	Turn-On Delay Time	V_{DC}=800V, V_{GS}=-4/18V I_D=20A, $R_{G(ext)}$=2.2Ω L_σ=80nH, T_j=175°C Inductive Load Eon includes diode reverse recovery		25		ns
t_r	Rise Time			18		ns
$t_{d(off)}$	Turn-Off Delay Time			14		ns
t_f	Fall Time			10		ns
E_{on}	Turn-On Energy			470		uJ
E_{off}	Turn-Off Energy			70		uJ

Reverse Diode Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
V_{SD}	Diode Forward Voltage	V_{GS}=-4V, I_{SD}=10A, T_j=25°C		4.4		V
I_S	Continuous Diode Forward Current	V_{GS}=-4V, T_j=25°C			40	A
$I_{S,pulse}$	Pulse Diode Current	V_{GS}=-4V, pulse width t_p limited by T_{jmax}		90		A
t_{rr}	Reverse Recovery Time	V_{DC}=800V, I_{SD}=20A -di$_F$/dt=2200A/μs T_j=25°C		29		ns
Q_{rr}	Reverse Recovery Charge			150		nC
I_{rrm}	Peak Reverse Recovery Current			10		A
V_{SD}	Diode Forward Voltage	V_{GS}=-4V, I_{SD}=10A, T_j=175°C		3.7		V
t_{rr}	Reverse Recovery Time	V_{DC}=800V, I_{SD}=20A -di$_F$/dt=2200A/μs T_j=175°C		39		ns
Q_{rr}	Reverse Recovery Charge			400		nC
I_{rrm}	Peak Reverse Recovery Current			20		A

Typical Performance

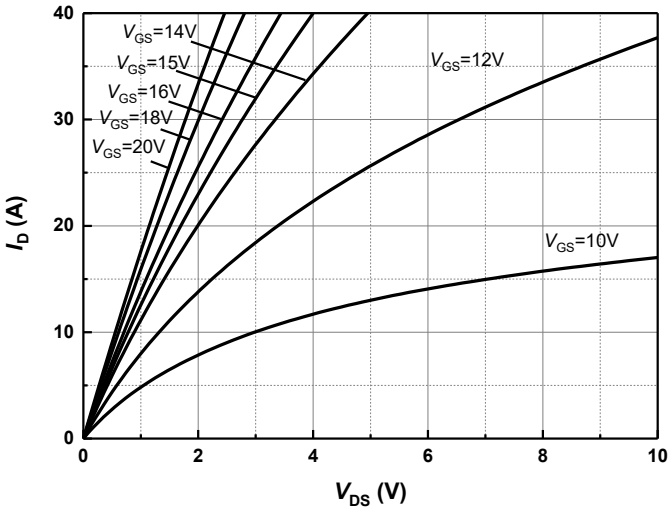


Figure 1 Typical Forward Output Characteristics at T_j=25°C

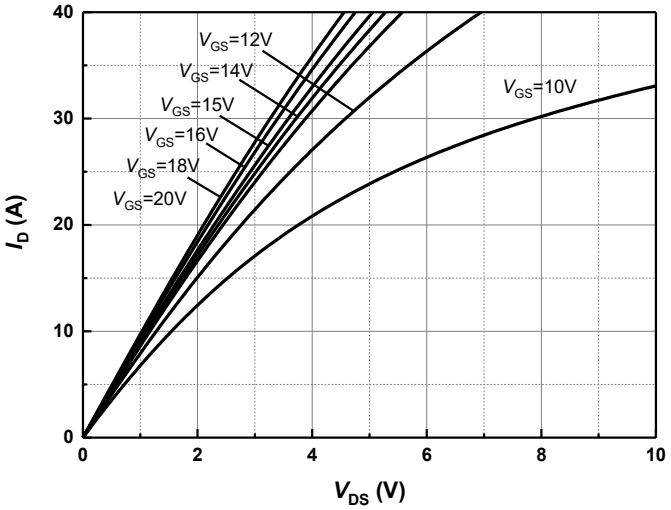


Figure 2 Typical Forward Output Characteristicsat T_j=175°C

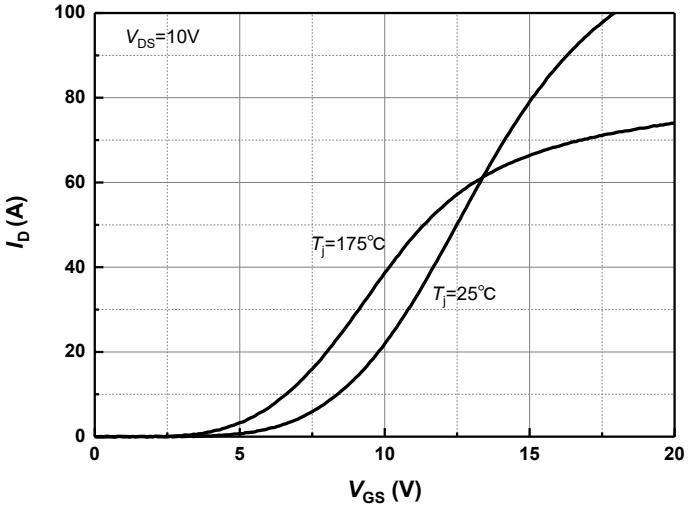


Figure 3 Transfer Characteristics for Various Temperature

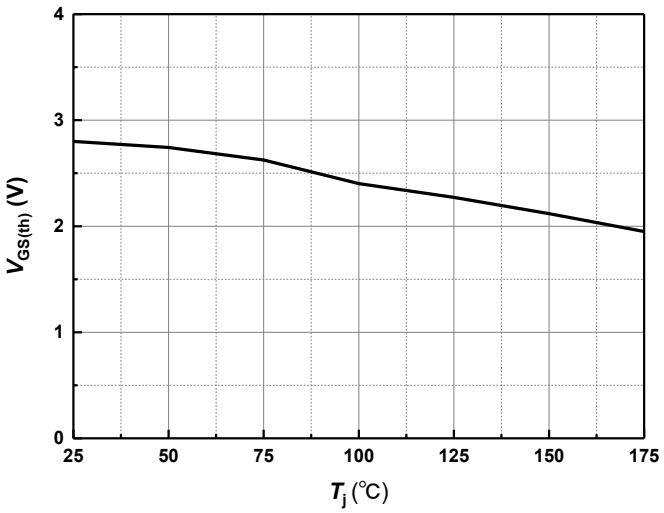


Figure 4 Threshold Voltage for Various Temperature

Typical Performance

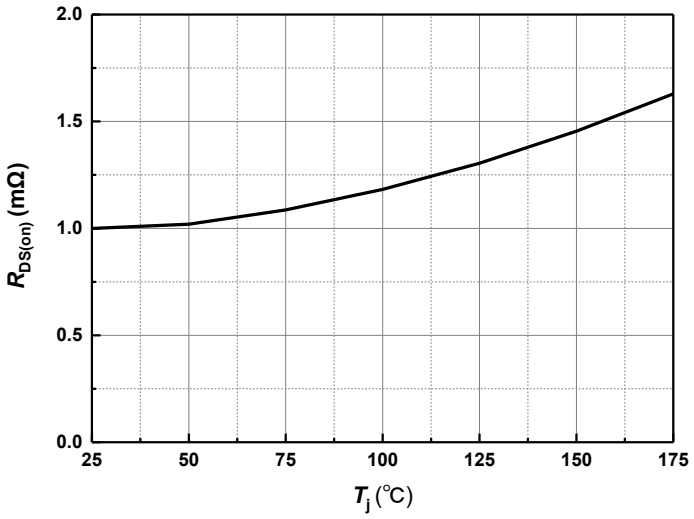


Figure 5 Normalized On-Resistance for Various Temperature

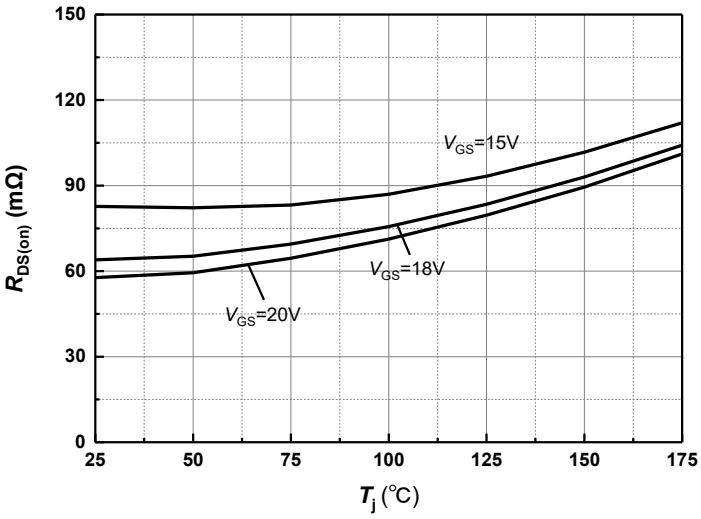


Figure 6 On-Resistance vs. Temperature for Various Gate-Source Voltage

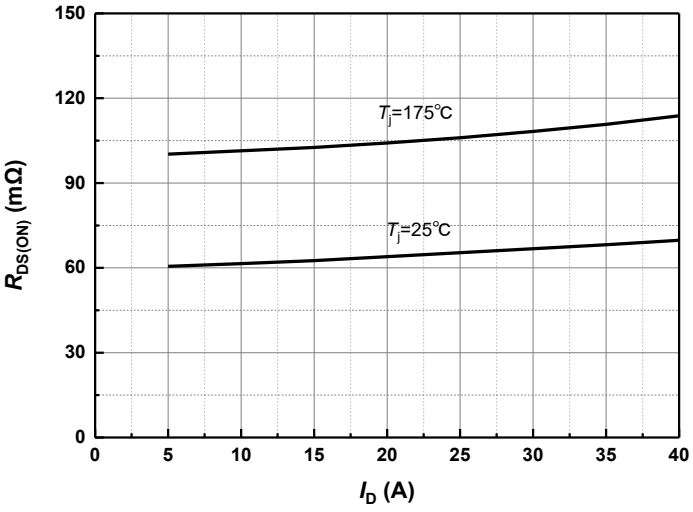


Figure 7 On-Resistance vs. Drain Current for Various Temperature

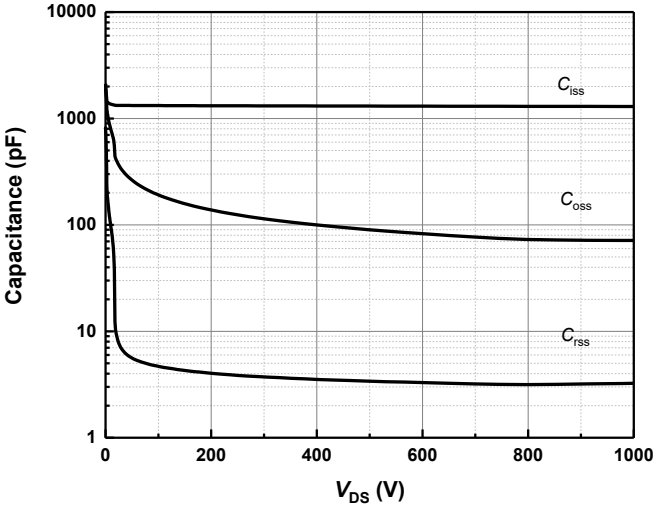


Figure 8 Capacitance vs. Drain-Source Voltage (0 - 1000V)

Typical Performance

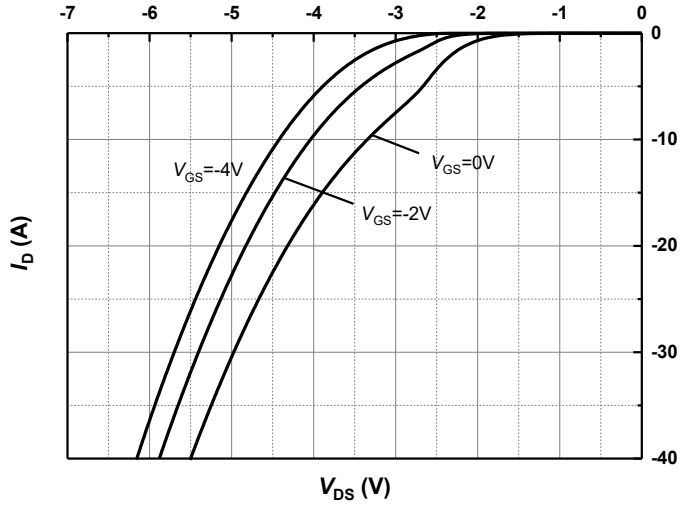


Figure 9 Body Diode Characteristics at T_j=25°C

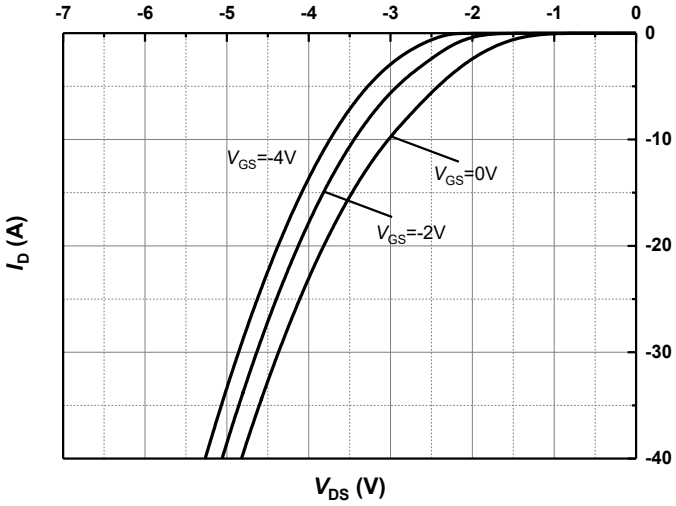


Figure 10 Body Diode Characteristics at T_j=175°C

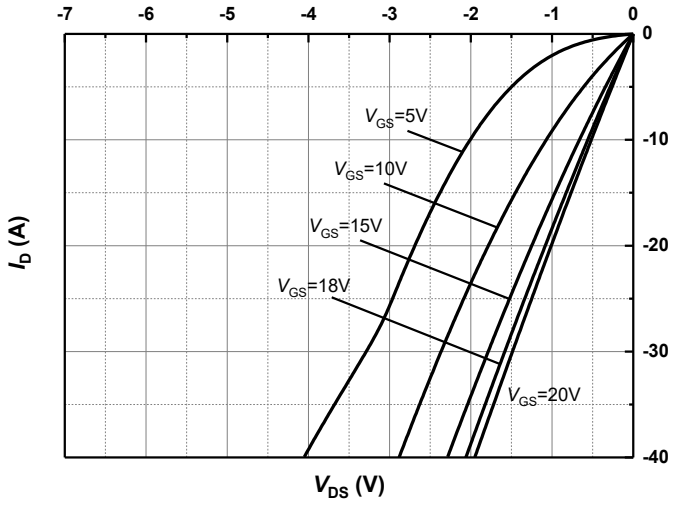


Figure 11 3rd Quadrant Characteristics at T_j=25°C

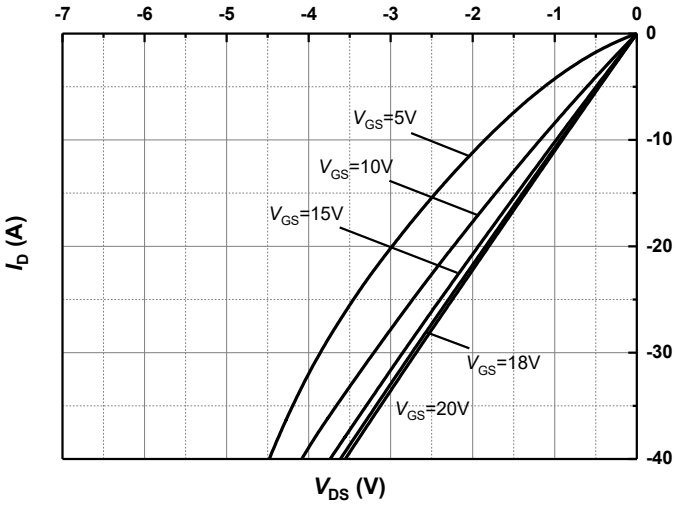


Figure 12 3rd Quadrant Characteristics at T_j=175°C

Typical Performance

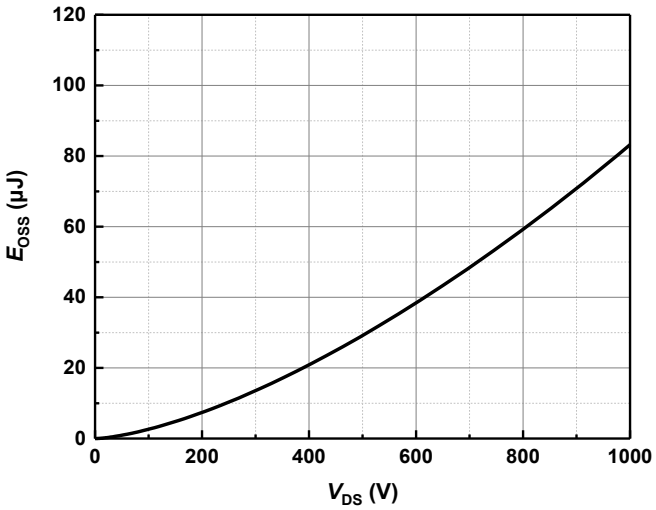


Figure 13 Output Capacitor stored Energy

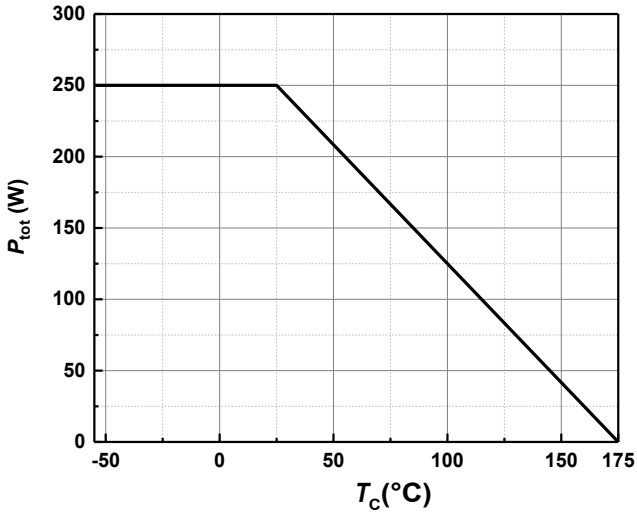


Figure 14 Maximum Power Dissipation Derating vs. Case Temperature

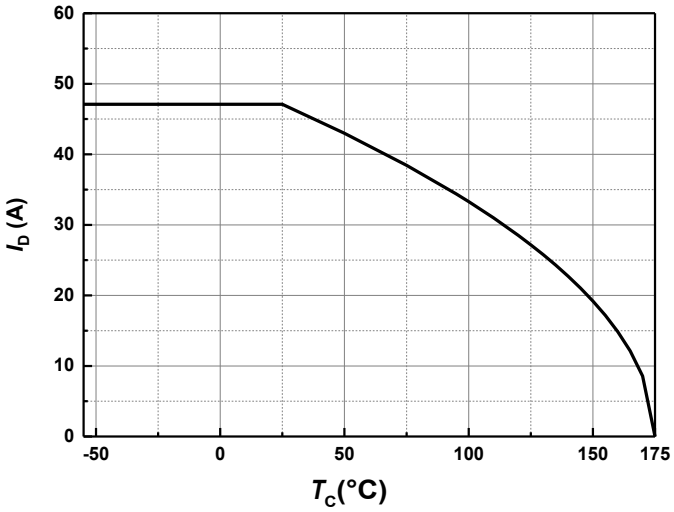


Figure 15 Continuous Drain Current Derating vs. Case Temperature

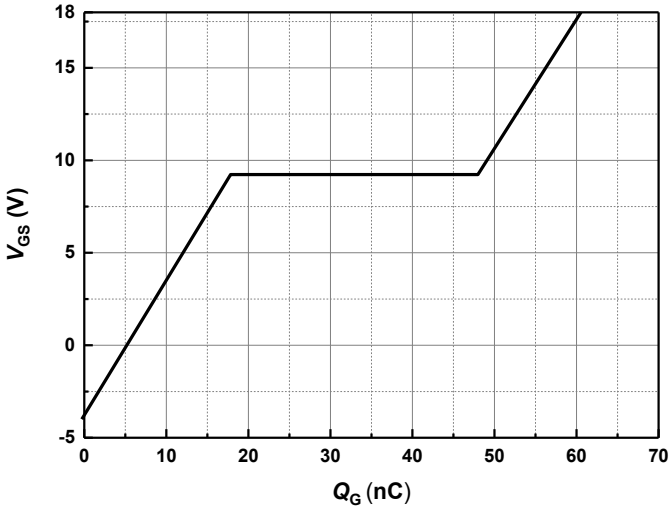


Figure 16 Gate Charge Characteristics

Typical Performance

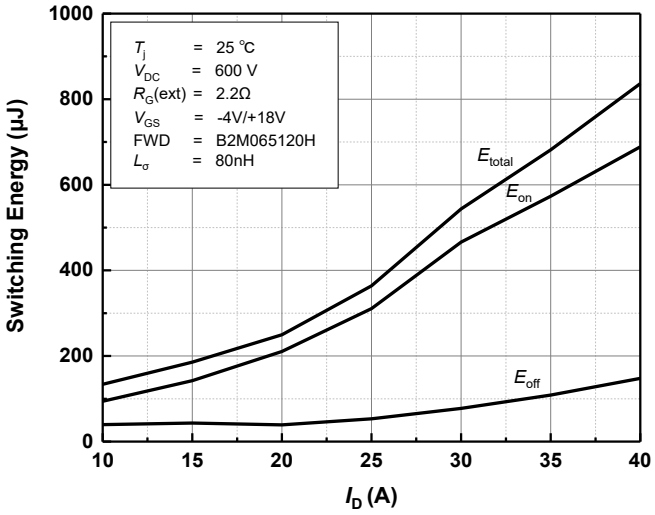


Figure 17 Clamped Inductive Switching Energy vs. Drain Current (V_{DC}= 600V) at T_j=25°C

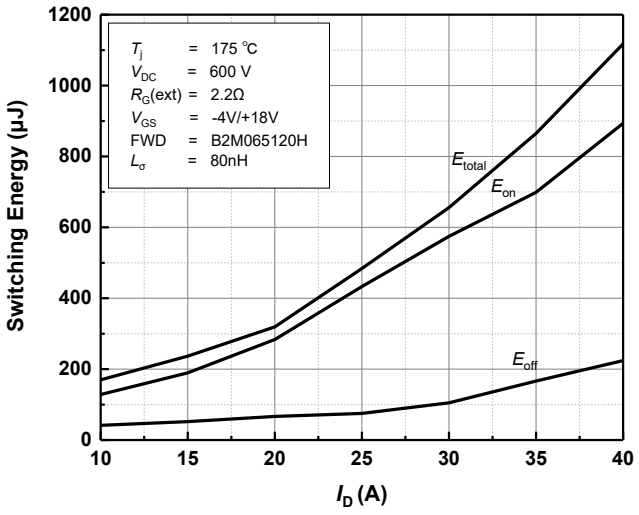


Figure 18 Clamped Inductive Switching Energy vs. Drain Current (V_{DC}= 600V) at T_j=175°C

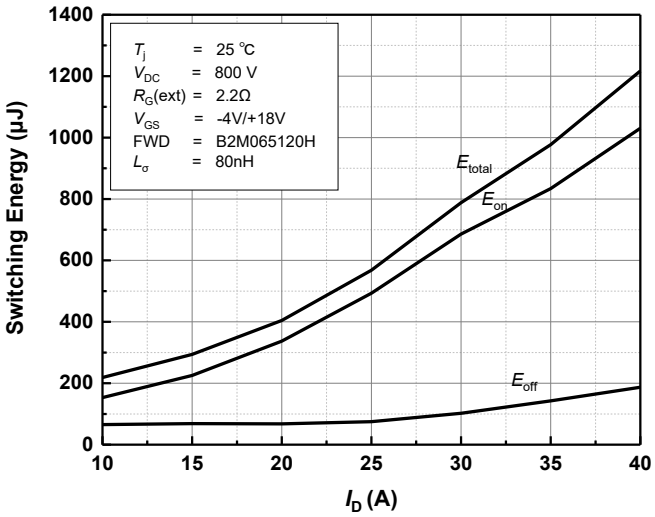


Figure 19 Clamped Inductive Switching Energy vs. Drain Current (V_{DC}= 800V) at T_j=25°C

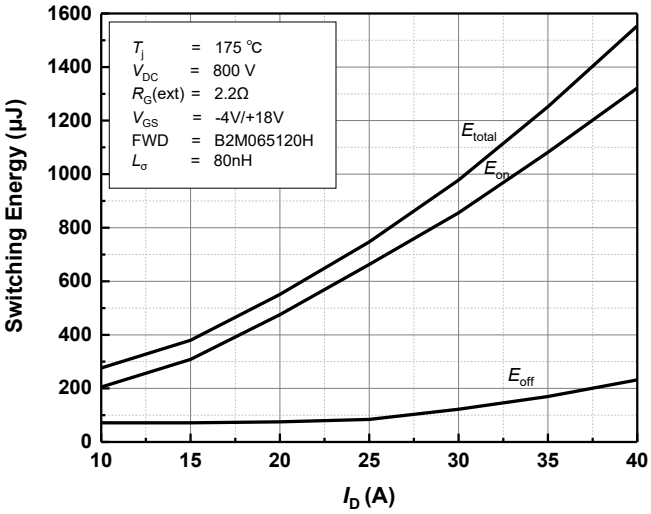


Figure 20 Clamped Inductive Switching Energy vs. Drain Current (V_{DC}= 800V) at T_j=175°C

Typical Performance

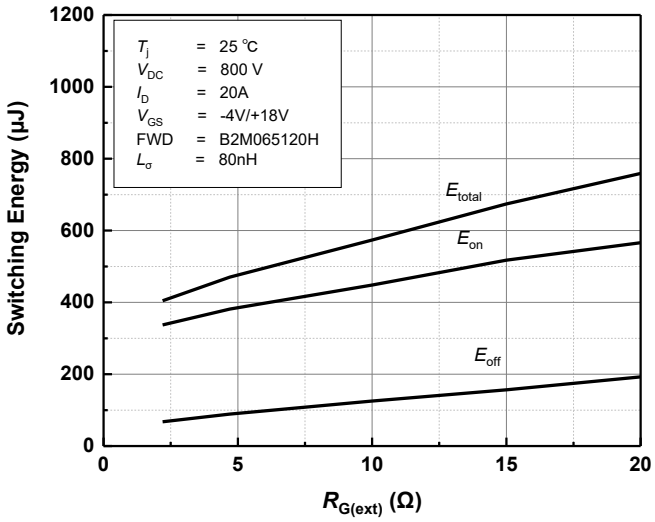


Figure 21 Clamped Inductive Switching Energy vs. External Gate Resistance at T_j=25°C

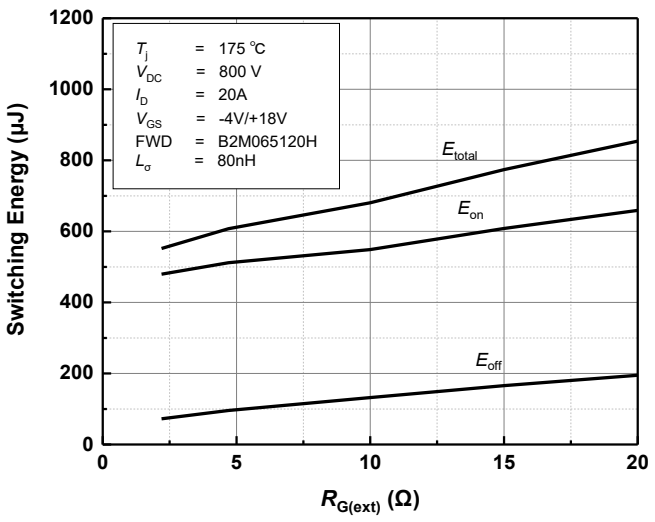


Figure 22 Clamped Inductive Switching Time vs. External Gate Resistance at T_j=175°C

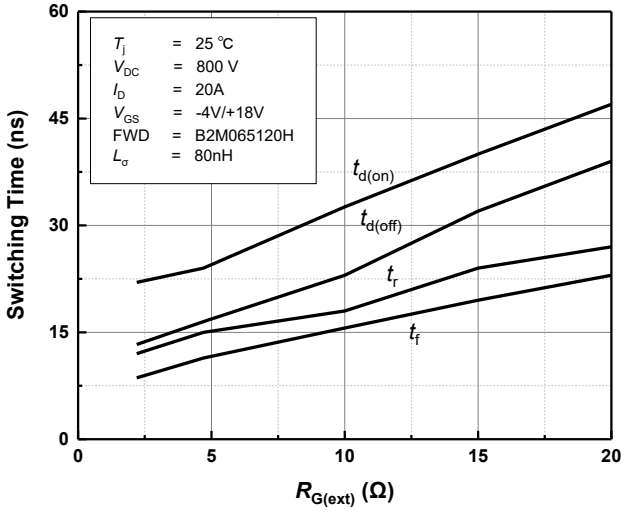


Figure 23 Clamped Inductive Switching Time vs. External Gate Resistance at T_j=25°C

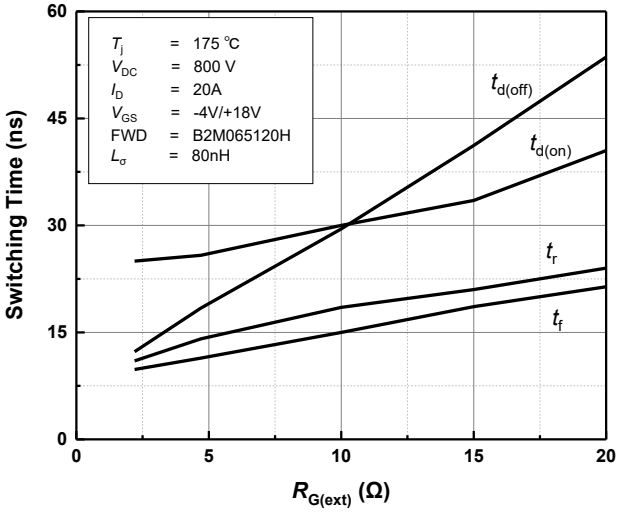


Figure 24 Clamped Inductive Switching Time vs. External Gate Resistance at T_j=175°C

Typical Performance

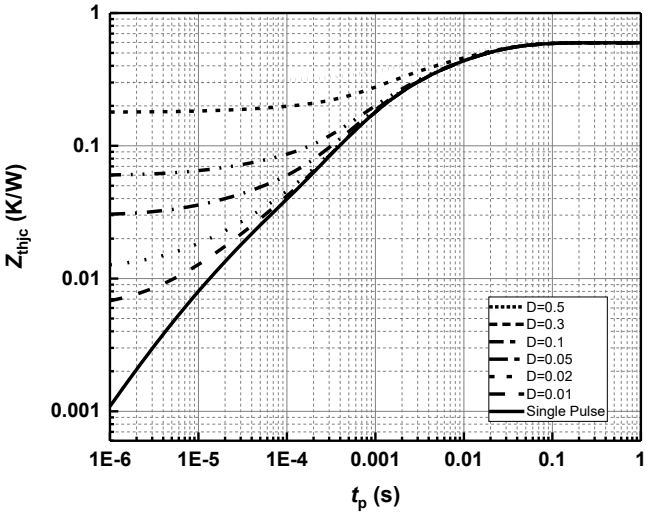


Figure 25 Transient Thermal Impedance (Junction - Case)

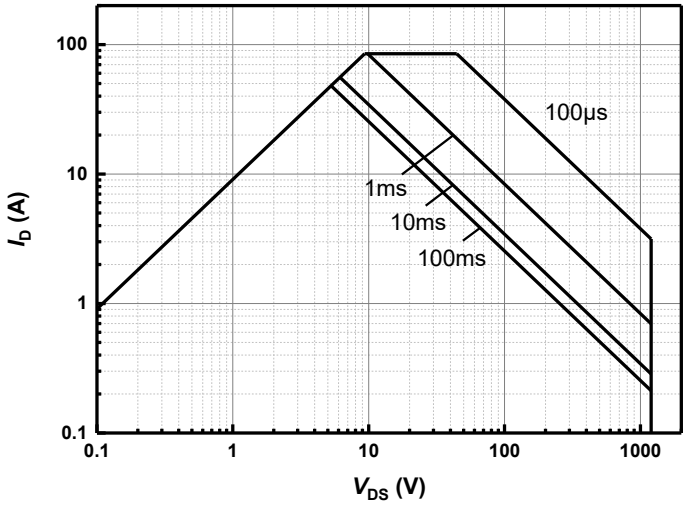
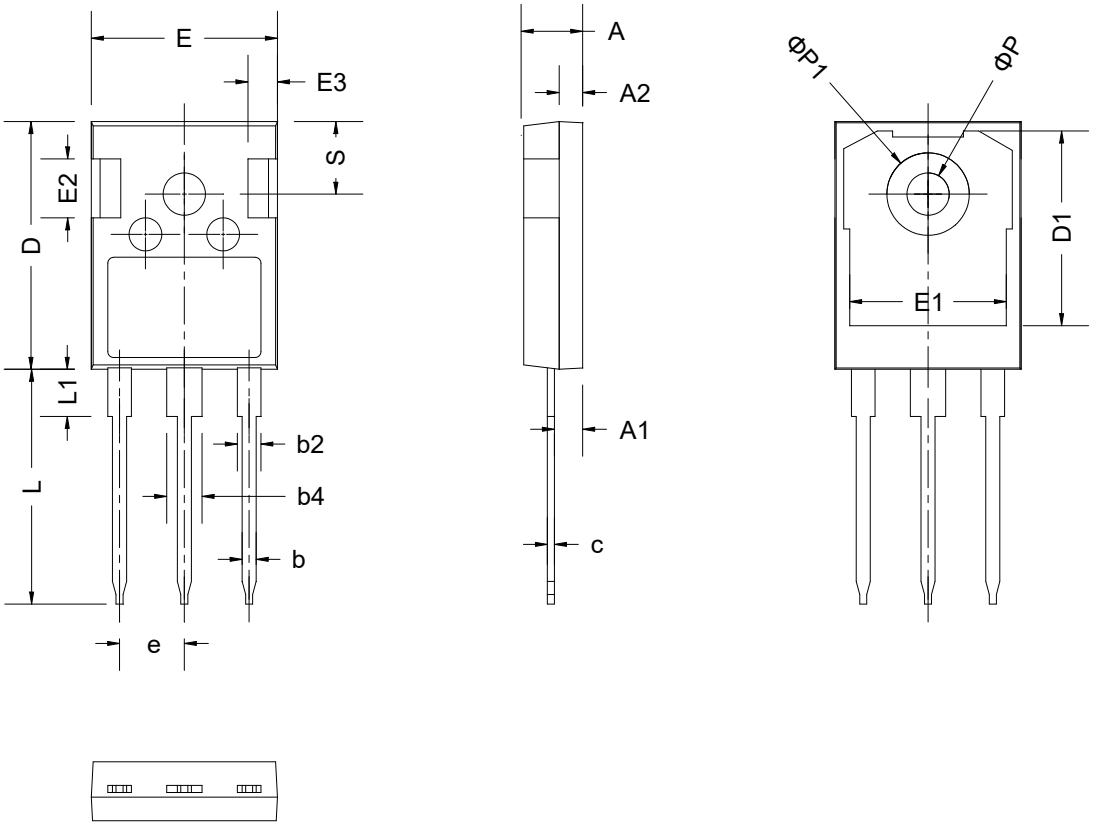


Figure 26 Forward Biased Safe Operating Area

Package Dimensions



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.59
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.80	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44 BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
ϕ P	3.40	3.60	3.80
ϕ P1	-	-	7.30
S	6.16 BSC		

Revision History

Document Version	Date of Release	Description of Changes
Rev. 0.0	2023-05-22	Draft datasheet created.

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